

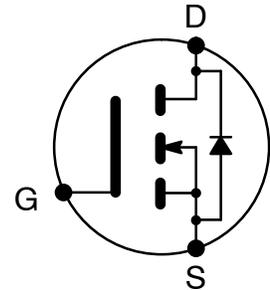


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NTE2397 MOSFET N-Ch, Enhancement Mode High Speed Switch TO220 Type Package

Features:

- Dynamic dv/dt Rating
- Repetitive Avalanche Rated
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements



Absolute Maximum Ratings:

| | |
|--|-------------------------------|
| Continuous Drain Current ($V_{GS} = 10V$), I_D | |
| $T_C = +25^\circ C$ | 10A |
| $T_C = +100^\circ C$ | 6.3A |
| Pulsed Drain Current (Note 1), I_{DM} | 40A |
| Power Dissipation ($T_C = +25^\circ C$), P_D | 125W |
| Derate Linearly Above $25^\circ C$ | 1.0W/ $^\circ C$ |
| Gate-to-Source Voltage, V_{GS} | $\pm 20V$ |
| Single Pulse Avalanche Energy (Note 2), E_{AS} | 520mJ |
| Avalanche Current (Note 1), I_{AR} | 10A |
| Repetitive Avalanche Energy (Note 1), E_{AR} | 13mJ |
| Peak Diode Recovery dv/dt (Note 3), dv/dt | 4V/ns |
| Operating Junction Temperature Range, T_J | -55° to $+150^\circ C$ |
| Storage Temperature Range, T_{stg} | -55° to $+150^\circ C$ |
| Lead Temperature (During Soldering, 1.6mm from case for 10sec), T_L | $+300^\circ C$ |
| Mounting Torque (6-32 or M3 Screw) | 10 lbf•in (1.1N•m) |
| Thermal Resistance, Junction-to-Case, R_{thJC} | 1.0 $^\circ C/W$ |
| Thermal Resistance, Junction-to-Ambient, R_{thJA} | 62 $^\circ C/W$ |
| Typical Thermal Resistance, Case-to-Sink (Flat, Greased Surface), R_{thCS} | 0.5 $^\circ C/W$ |

Note 1. Repetitive rating; pulse width limited by maximum junction temperature.

Note 2. $V_{DD} = 50V$, starting $T_J = +25^\circ C$, $L = 9.1 \leq H$, $R_G = 25 \pm$, $I_{AS} = 10A$

Note 3. $I_{SD} \leq 10A$, $di/dt \leq 120A/\leq s$, $V_{DD} \leq V_{(BR)DSS}$, $T_J \leq +150^\circ C$

Electrical Characteristics: ($T_J = +25^\circ\text{C}$ unless otherwise specified)

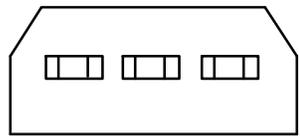
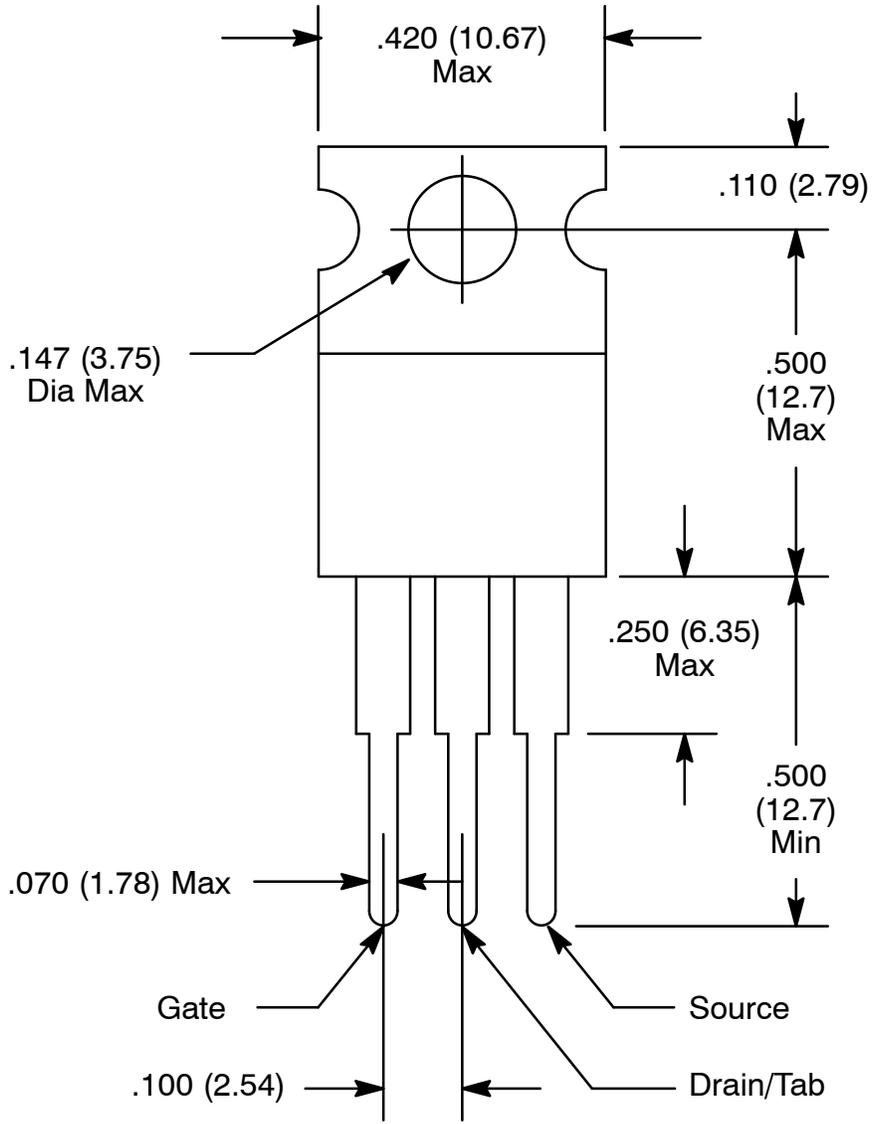
| Parameter | Symbol | Test Conditions | Min | Typ | Max | Unit |
|--------------------------------------|---------------------------|---|-----|------|------|--------------------|
| Drain-to-Source Breakdown Voltage | $V_{(BR)DSS}$ | $V_{GS} = 0V, I_D = 250\leq A$ | 400 | - | - | V |
| Breakdown Voltage Temp. Coefficient | $\frac{V_{(BR)DSS}}{T_J}$ | Reference to $+25^\circ\text{C}, I_D = 1\text{mA}$ | - | 0.49 | - | $V/^\circ\text{C}$ |
| Static Drain-to-Source On-Resistance | $R_{DS(on)}$ | $V_{GS} = 10V, I_D = 6A, \text{Note 4}$ | - | - | 0.55 | \pm |
| Gate Threshold Voltage | $V_{GS(th)}$ | $V_{DS} = V_{GS}, I_D = 250\leq A$ | 2.0 | - | 4.0 | V |
| Forward Transconductance | g_{fs} | $V_{DS} = 50V, I_D = 6A, \text{Note 4}$ | 5.8 | - | - | mhos |
| Drain-to-Source Leakage Current | I_{DSS} | $V_{DS} = 400V, V_{GS} = 0V$ | - | - | 25 | $\leq A$ |
| | | $V_{DS} = 320V, V_{GS} = 0V, T_J = +125^\circ\text{C}$ | - | - | 250 | $\leq A$ |
| Gate-to-Source Forward Leakage | I_{GSS} | $V_{GS} = 20V$ | - | - | 100 | nA |
| Gate-to-Source Reverse Leakage | I_{GSS} | $V_{GS} = -20V$ | - | - | -100 | nA |
| Total Gate Charge | Q_g | $I_D = 10A, V_{DS} = 320V, V_{GS} = 10V, \text{Note 4}$ | - | - | 63 | nC |
| Gate-to-Source Charge | Q_{gs} | | - | - | 9.0 | nC |
| Gate-to-Drain ("Miller") Charge | Q_{gd} | | - | - | 32 | nC |
| Turn-On Delay Time | $t_{d(on)}$ | $V_{DD} = 200V, I_D = 10A, R_G = 9.1\pm, R_D = 20\pm, \text{Note 4}$ | - | 14 | - | ns |
| Rise Time | t_r | | - | 27 | - | ns |
| Turn-Off Delay Time | $t_{d(off)}$ | | - | 50 | - | ns |
| Fall Time | t_f | | - | 24 | - | ns |
| Internal Drain Inductance | L_D | Between lead, .250in. (6.0) mm from package and center of die contact | - | 4.5 | - | nH |
| Internal Source Inductance | L_S | | - | 7.5 | - | nH |
| Input Capacitance | C_{iss} | $V_{GS} = 0V, V_{DS} = 25V, f = 1\text{MHz}$ | - | 1400 | - | pF |
| Output Capacitance | C_{oss} | | - | 330 | - | pF |
| Reverse Transfer Capacitance | C_{rss} | | - | 120 | - | pF |

Source-Drain Ratings and Characteristics:

| Parameter | Symbol | Test Conditions | Min | Typ | Max | Unit |
|--|----------|---|-----|-----|-----|----------|
| Continuous Source Current (Body Diode) | I_S | | - | - | 10 | A |
| Pulsed Source Current (Body Diode) | I_{SM} | Note 1 | - | - | 40 | A |
| Diode Forward Voltage | V_{SD} | $T_J = +25^\circ\text{C}, I_S = 10A, V_{GS} = 0V, \text{Note 4}$ | - | - | 2.0 | V |
| Reverse Recovery Time | t_{rr} | $T_J = +25^\circ\text{C}, I_F = 10A, di/dt = 100A/\leq s, \text{Note 4}$ | - | 370 | 790 | ns |
| Reverse Recovery Charge | Q_{rr} | | - | 3.8 | 8.2 | $\leq C$ |
| Forward Turn-On Time | t_{on} | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$) | | | | |

Note 1. Repetitive rating; pulse width limited by maximum junction temperature.

Note 4. Pulse width $\leq 300\leq s$; duty cycle $\leq 2\%$.



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